

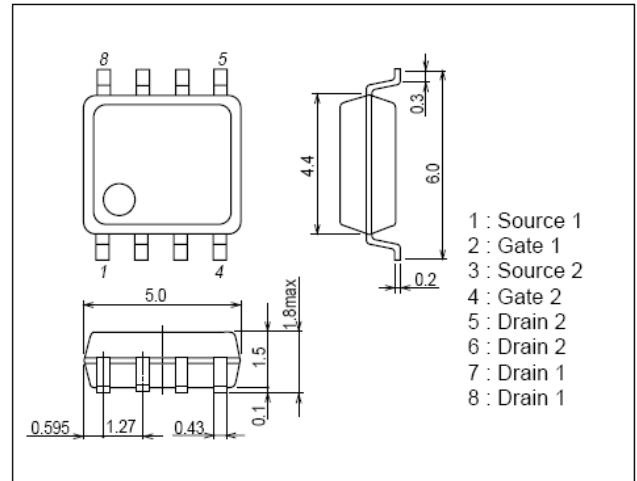
### Features

- Low On resistance.
- +4.5V drive.
- RoHS compliant.



### Package Dimensions

unit : mm  
SOP-8

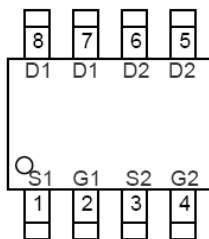


### Specifications

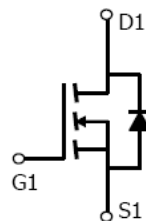
Absolute Maximum Ratings at  $T_a=25^{\circ}\text{C}$

Parameter	Symbol	Conditions	Ratings		Unit
			N-Ch	P-Ch	
Drain-to-Source Voltage	$V_{DSS}$		30	-30	V
Gate-to-Source Voltage	$V_{GSS}$		$\pm 20$	$\pm 20$	V
Drain Current (DC)	$I_D$		6.9	-6	A
Drain Current (Pulse)	$I_{DP}$	$PW \leq 10\mu\text{s}$ , duty cycle $\leq 1\%$	30	-30	A
Allowable Power Dissipation	$P_D$	Mounted on a ceramic board (1000mm <sup>2</sup> ×0.8mm) 1unit	1.3	1.3	W
Total Dissipation	$P_T$	Mounted on a ceramic board (1000mm <sup>2</sup> ×0.8mm)	1.7	1.7	W
Channel Temperature	$T_{ch}$		150		$^{\circ}\text{C}$
Storage Temperature	$T_{stg}$		-55~+150		$^{\circ}\text{C}$

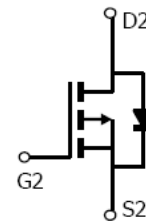
### Pin Description



TOP VIEW  
SOP-8



n-channel



p-channel

**N-Channel Electrical Characteristics at  $T_a=25^{\circ}\text{C}$**

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$			1	$\mu\text{A}$
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0	1.6	2.0	V
Static Drain-to-Source On-State Resistance	$R_{DS(ON)}$	$I_D=6.9\text{A}, V_{GS}=10\text{V}$		18	30	$\text{m}\Omega$
	$R_{DS(ON)}$	$I_D=5\text{A}, V_{GS}=4.5\text{V}$		28	38	$\text{m}\Omega$
Input Capacitance	$C_{iss}$	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		680	820	pF
Output Capacitance	$C_{oss}$	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		102		pF
Reverse Transfer Capacitance	$C_{rss}$	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		77		pF
Turn-on Delay Time	$t_{d(on)}$	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=2.2\Omega,$ $R_{GEN}=3\Omega$		4.6	7	nS
Rise Time	$t_r$			4.1	6	nS
Turn-off Delay Time	$t_{d(off)}$			20.6	30	nS
Fall Time	$t_f$			5.2	8	nS
Total Gate Charge	$Q_g$	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=6.9\text{A}$		6.74	8.1	nC
Gate-to-Source Charge	$Q_{gs}$			1.82		nC
Gate-to-Drain "Miller" Charge	$Q_{gd}$			3.2		nC
Diode Forward Voltage	$V_{SD}$	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.76	1.3	V

**N-Channel Typical Characteristics at  $T_a=25^{\circ}\text{C}$**

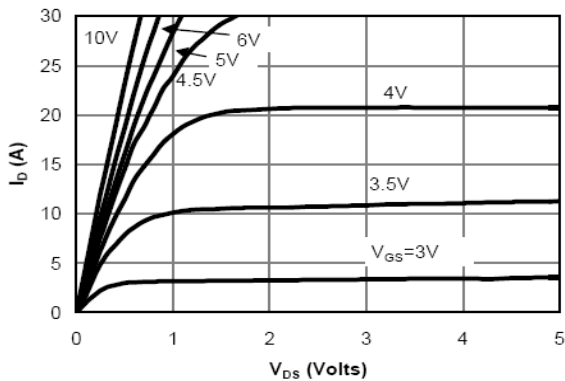


Fig 1: On-Region Characteristics

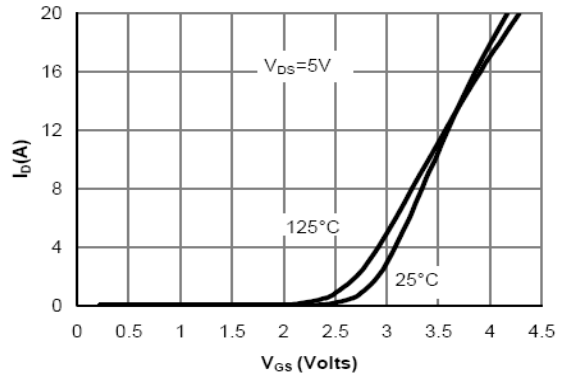


Figure 2: Transfer Characteristics

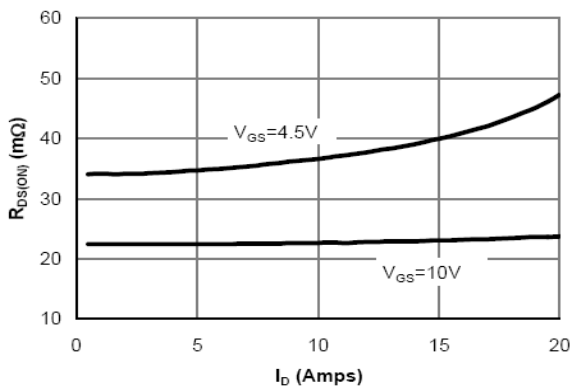


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

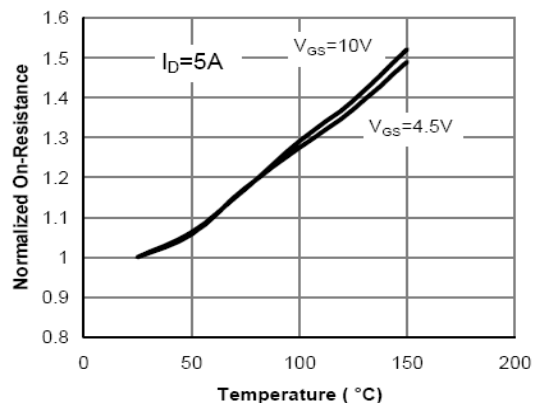


Figure 4: On-Resistance vs. Junction Temperature

N-Channel Typical Characteristics at  $T_a=25^{\circ}\text{C}$  (Continues)

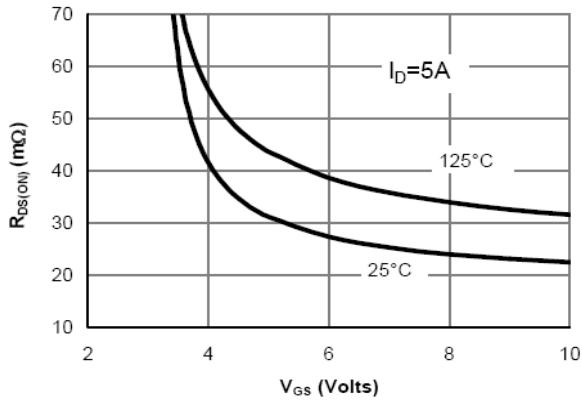


Figure 5: On-Resistance vs. Gate-Source Voltage

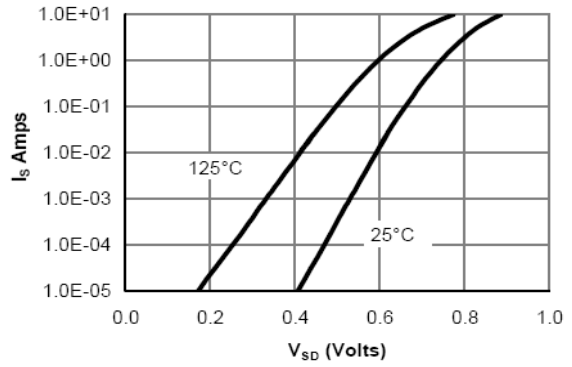


Figure 6: Body diode characteristics

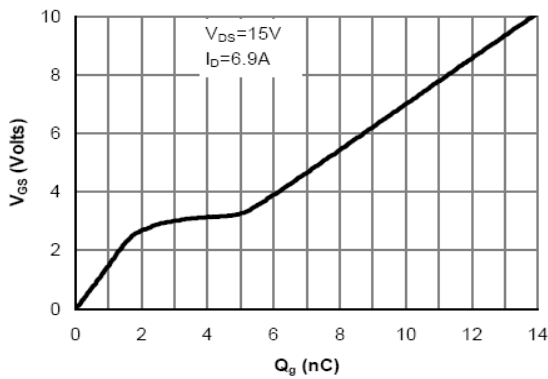


Figure 7: Gate-Charge characteristics

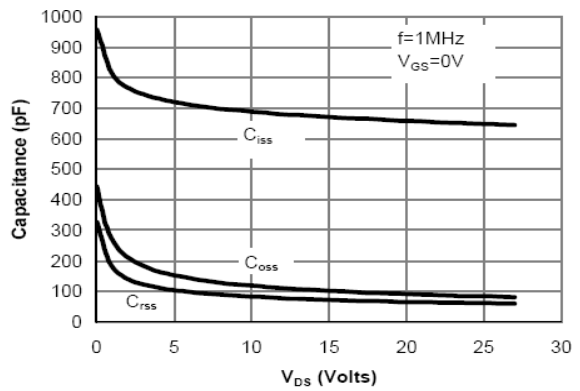


Figure 8: Capacitance Characteristics

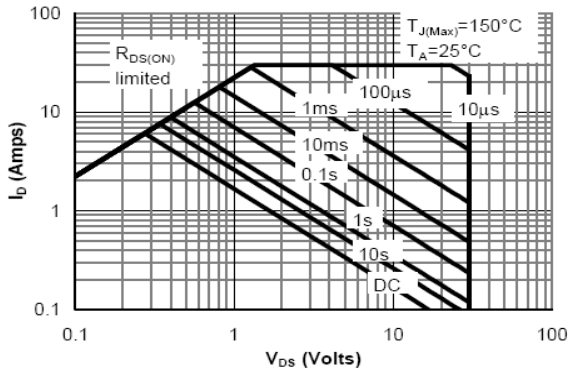


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

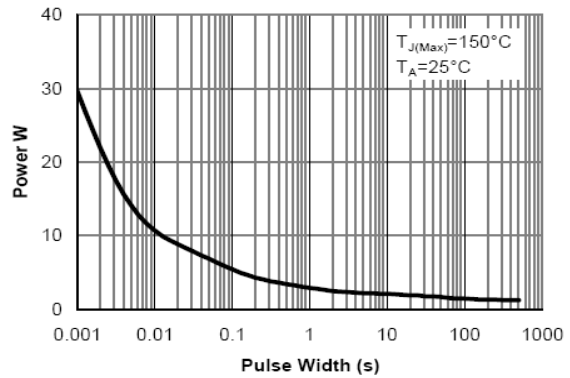


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

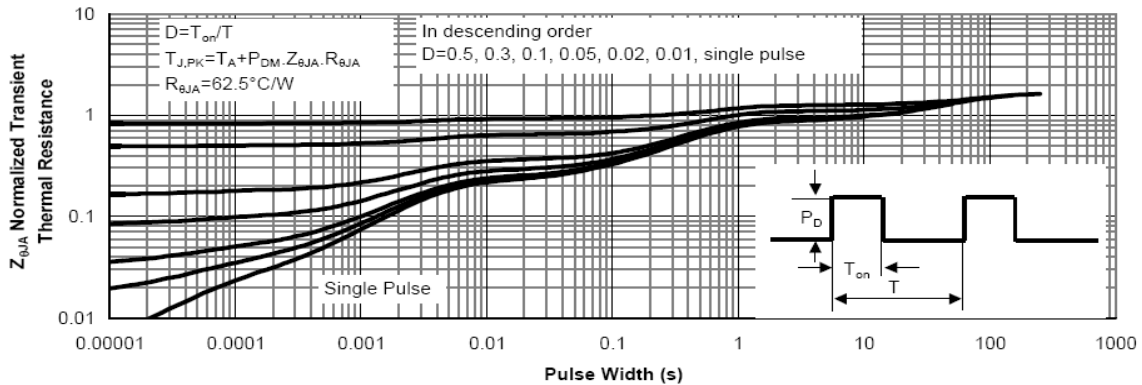


Figure 11: Normalized Maximum Transient Thermal Impedance

**P-Channel Electrical Characteristics at  $T_a=25^{\circ}\text{C}$**

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-30			V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-24\text{V}, V_{GS}=0\text{V}$			-1	$\mu\text{A}$
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	-1.0	-1.4	-2.0	V
Static Drain-to-Source On-State Resistance	$R_{DS(ON)}$	$I_D=-6\text{A}, V_{GS}=-10\text{V}$		38	46	m $\Omega$
	$R_{DS(ON)}$	$I_D=-5\text{A}, V_{GS}=-4.5\text{V}$		56	72	m $\Omega$
Input Capacitance	$C_{iss}$	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		920	1100	pF
Output Capacitance	$C_{oss}$	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		190		pF
Reverse Transfer Capacitance	$C_{rss}$	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		122		pF
Turn-on Delay Time	$t_{d(on)}$	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=2.7\Omega,$ $R_{GEN}=3\Omega$		7.7	11.5	nS
Rise Time	$t_r$			5.7	8.5	nS
Turn-off Delay Time	$t_{d(off)}$			20.2	30	nS
Fall Time	$t_f$			9.5	14	nS
Total Gate Charge	$Q_g$	$V_{DS}=-15\text{V}, V_{GS}=-10\text{V}, I_D=-6\text{A}$		9.6	11.6	nC
Gate-to-Source Charge	$Q_{gs}$			2.7	11.6	nC
Gate-to-Drain "Miller" Charge	$Q_{gd}$			4.5		nC
Diode Forward Voltage	$V_{SD}$	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.8	-1.3	V

**P-Channel Typical Characteristics at  $T_a=25^{\circ}\text{C}$**

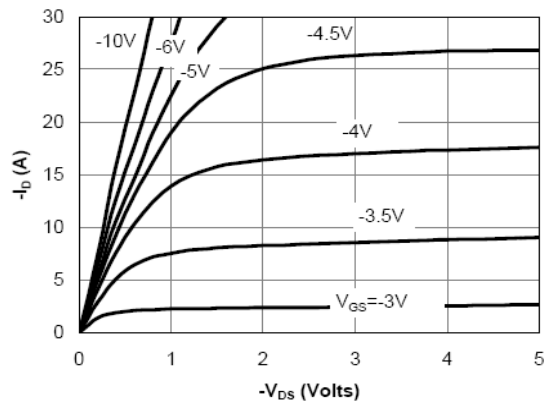


Fig 1: On-Region Characteristics

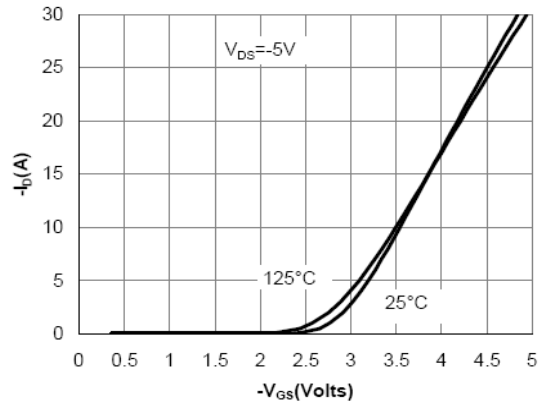


Figure 2: Transfer Characteristics

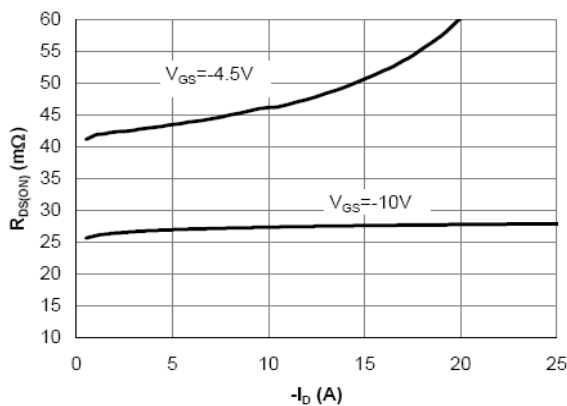


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

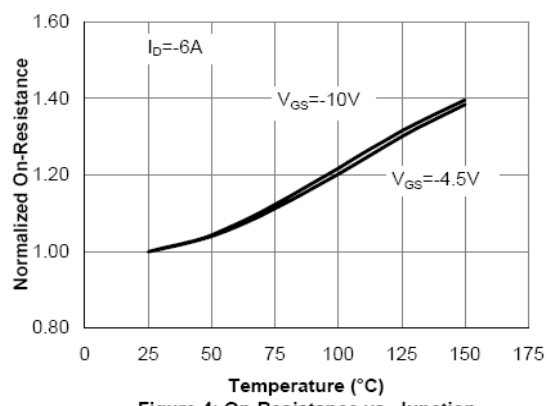


Figure 4: On-Resistance vs. Junction Temperature

P-Channel Typical Characteristics at  $T_a=25^{\circ}\text{C}$  (Continues)

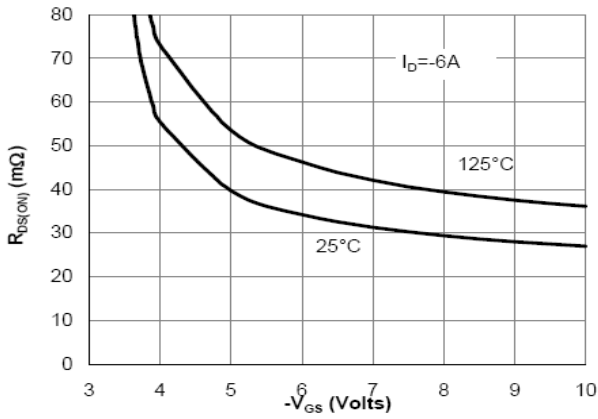


Figure 5: On-Resistance vs. Gate-Source Voltage

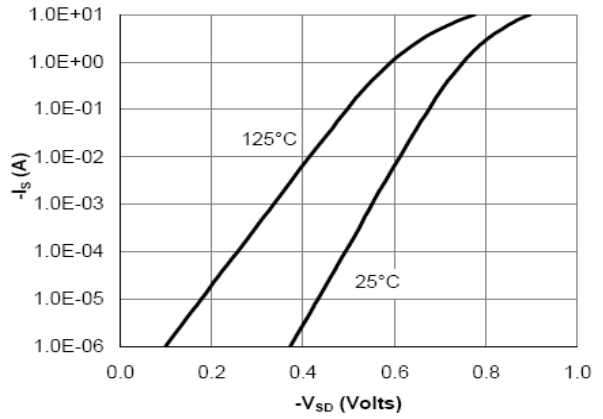


Figure 6: Body-Diode Characteristics

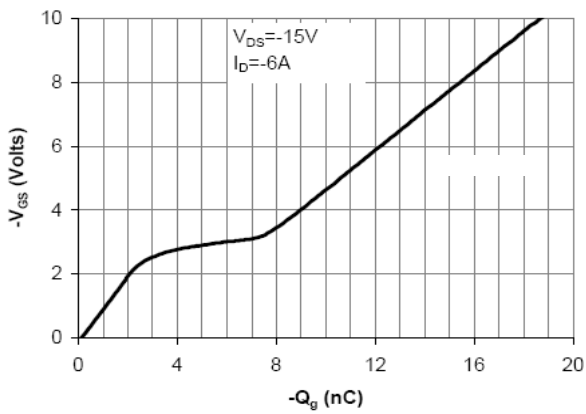


Figure 7: Gate-Charge Characteristics

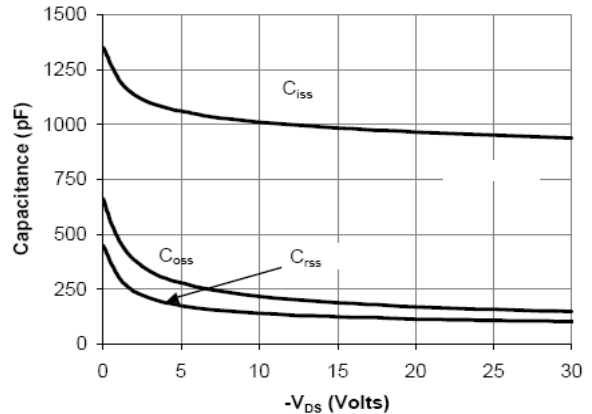


Figure 8: Capacitance Characteristics

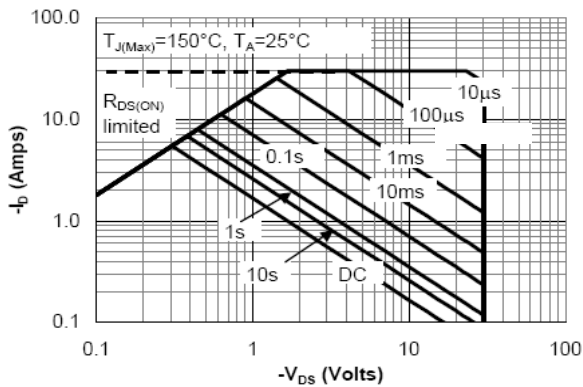


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

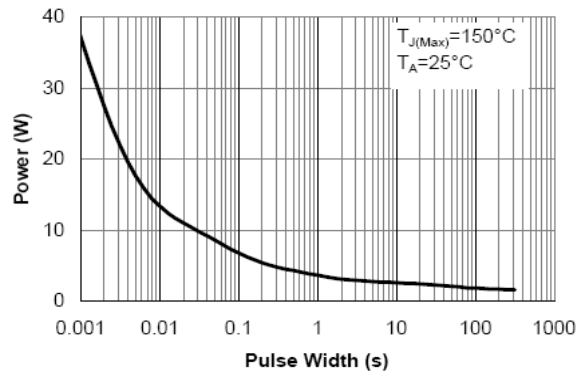


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

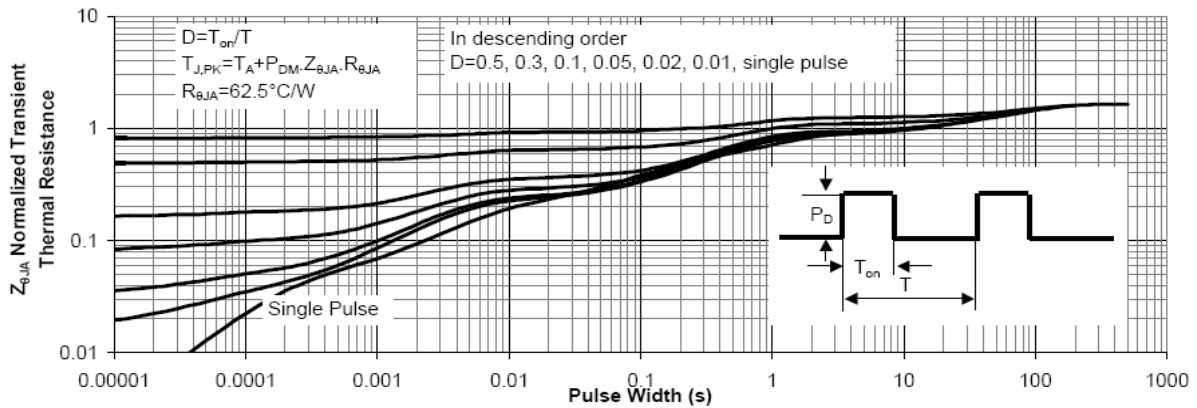


Figure 11: Normalized Maximum Transient Thermal Impedance